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41 Talking about modules and delivery

77%

Harley Davis, Pierre Parquier, Nitsan Séniak
ACM SIGPLAN Lisp Pointers, Proceedings of the 1994 ACM conference on LISP and functional programming July 1994
Volume VII Issue 3

Adding a module system to LISP enhances program security and efficiency, and help the programmer master the complexity of large systems, thus facilitating application and delivery. TALK's module system is based on a simple compilation model which takes macros into account and provides a solid basis for automatic module management tools. Higher-level structuring entities—libraries and executables—group modules into deliverable goods. The module system is secure because it validat ...

42 Experiences developing and using an object-oriented library for 77% program manipulation

Tim Bingham , Nancy Hobbs , Dave Husson ACM SIGPLAN Notices , Proceedings of the eighth annual conference on Object-oriented programming systems, languages, and applications October 1993



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Member Services Join IEEE Establish IEE Web Account Access the IEEE Member Digital Librar	Wolff, J.E.; Florke, H.; Cremers, A.B.; Advances in Digital Libraries, 2000. ADL 2000. Proceedings. IEEE, 2000 Page(s): 141-150
Print Format	[Abstract] [PDF Full-Text (312 KB)] IEEE CNF

3 A metadata approach for designing configurable interfaces in digital libraries

de Carvalho Moura, A.M.; Estevao da Silva, L.A.; Machado Campos, M.L.; Database and Expert Systems Applications, 2001. Proceedings. 12th Internatic Workshop on , 2001

Page(s): 942 -947

[Abstract] [PDF Full-Text (544 KB)] IEEE CNF

4 PM: a system t supp rt the automatic acquisiti n f pr gramming knowledge

Reynolds, R.G.; Maletic, J.I.; Porvin, S.E.;

Knowledge and Data Engineering, IEEE Transactions on, Volume: 2 Issue: 3, 5